

# **TEST REPORT**

# No.I17N00063-EMC

for

Power Idea Technology (Shenzhen) Co., Ltd.

**TD-LTE** digital mobile phone

Model Name: MD501

FCC ID: ZLE-MD501

## with

Hardware Version: 1.04

Software Version: MD501\_US\_1.003.00\_20170103

Issued Date: 2017-02-28

**Test Laboratory:** 

FCC 2.948 Listed: No.342690 IC O.A.T.S listed: No.21856-1

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of CTTL.

#### **Test Laboratory:**

CTTL, Telecommunication Technology Labs, Academy of Telecommunication Research, MIIT No.52, HuayuanNorth Road, Haidian District, Beijing, P. R. China 100191.

Tel:+86(0)10-62304633, Fax:+86(0)10-62304633Email:cttl@chinattl.com, website:www.chinattl.com

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# **REPORT HISTORY**

Report Number	Revision	Description	Issue Date
I17N00063-EMC	Rev.0	1st edition	2017-02-28



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# 1. Test Laboratory

# 1.1. Testing Location

Address:

TCL International E city No. 1001 Zhongshanyuan Road, Nanshan

District, Shenzhen, Guangdong, China

Postal Code:

518048

Telephone:

+86(755)33322000

Fax:

+86(755)33322001

## 1.2. Testing Environment

Normal Temperature:

15-35℃

Relative Humidity:

20-75%

# 1.3. Project data

Testing Start Date:

2017-01-18

Testing End Date:

2017-02-13

#### 1.4. Signature

Du Zhaoxuan

(Prepared this test report)

Zhang Yunzhuan

(Reviewed this test report)

Cao Junfei

Director of the laboratory

(Approved this test report)



# 2. Client Information

## 2.1. Applicant Information

Company Name: Power Idea Technology (Shenzhen) Co., Ltd.

4th Floor, A Section , Languang Science&technology Building , No.7

Address: Xinxi RD , Hi-Tech Industrial Park North , Nanshan District ,

ShenZhen, P.R.C.

## 2.2. Manufacturer Information

Company Name: Power Idea Technology (Shenzhen) Co., Ltd.

4th Floor, A Section , Languang Science&technology Building , No.7

Address: Xinxi RD , Hi-Tech Industrial Park North , Nanshan District ,

ShenZhen, P.R.C.



# 3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

#### 3.1. About EUT

Description TD-LTE digital mobile phone

Model Name MD501
FCC ID ZLE-MD501
IC number 11113A-MD501

The Equipment Under Test (EUT) are a model of Smart phone with integrated antenna.

The EUT supports GPRS service and EGPRS service. It has Bluetooth and WLAN functions.

Remark: The above EUT's information is declared by manufacturer. Please refer to the specifications or user's manual for more detailed information.

#### 3.2. Internal Identification of EUT

**EUT ID\*** SN or IMEI

EUT1 867453021949667

## 3.3. Internal Identification of AE

AE ID*	Description	SN
AE1	Battery	/
AE2	Travel charger	/
AE3	USB cable	/

AE1

Model Li-ion Rechargeable Battery

Manufacturer Springpower Technology (Shenzhen) Co., LTD

Capacitance 3950mAh Nominal Voltage 3.8V

AE2

Model HKC0055010-2D

Manufacturer SHENZHEN HUNTKEY ELECTRIC CO., LTD.

SN 805B901675000015

AE3

Model Micro 5PIN

Manufacturer Shenzhen Dechangsheng Electronic Technology Co., Ltd.

<sup>\*</sup>EUT ID: is used to identify the test sample in the lab internally.

<sup>\*</sup>AE ID: is used to identify the test sample in the lab internally.

Charging mode

USB mode



# 3.4. EUT set-ups

EUT set-up No. Combination of EUT and AE Remarks

Set.1 EUT1+ AE1 + AE2+ AE3

Set.2 EUT1+ AE1 + AE3



# 4. Reference Documents

# 4.1. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part 15,	Padia fraguanay dayigaa	10-1-2015
Subpart B	Radio frequency devices	Edition
	Methods of Measurement of Radio-Noise Emissions from	
ANSI C63.4	Low-Voltage Electrical and Electronic Equipment in the	2014
	Range of 9 kHz to 40 GHz	



# 5. LABORATORY ENVIRONMENT

Semi-anechoic chamber did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 30 °C
Relative humidity	Min. = 35 %, Max. = 60 %
Shielding effectiveness	0.014MHz-1MHz,>60dB;
	1MHz-18000MHz,>90dB
Electrical insulation	> 2MΩ
Ground system resistance	< 4 Ω
Normalised site attenuation (NSA)	$< \pm 4$ dB, 3 m distance, from 30 to 1000 MHz

**Shield room** did not exceed following limits along the EMC testing:

	e e
Temperature	Min. = 15 °C, Max. = 30 °C
Relative humidity	Min. =35 %, Max. = 60 %
Shielding effectiveness	0.014MHz-1MHz,>60dB;
	1MHz-10000MHz,>90dB
Electrical insulation	> 2MΩ
Ground system resistance	< 4 Ω

Fully-anechoic chamber did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 30 °C
Relative humidity	Min. = 35 %, Max. = 60 %
Shielding effectiveness	0.014MHz-1MHz,>60dB;
	1MHz-18000MHz,>90dB
Electrical insulation	> 2MΩ
Ground system resistance	<4 Ω
Voltage Standing Wave Ratio (VSWR)	≤ 6 dB, from 1 to 18 GHz, 3 m distance
Uniformity of field strength	Between 0 and 6 dB, from 80 to 3000 MHz



# 6. SUMMARY OF TEST RESULTS

Abbreviations used in this clause:	
Р	Pass
NA	Not applicable
F	Fail

Items	Test Name	Clause in FCC rules	Section in this report	Verdict
1	Radiated Emission	15.109(a)	A.1	Р
2	Conducted Emission	15.107(a)	A.2	Р



# 7. Test Facilities Utilized

NO.	NAME	TYPE	SERIES	PRODUCER	CALDUE	CAL
			NUMBER		DATE	PERIOD
1.	Test Receiver	ESCI	100701	R&S	2017.08.09	1 year
2.	Test Receiver	ESR7	101675	R&S	2017.07.21	1 year
3.	Spectrum Analyzer	FSP 40	100378	R&S	2017.12.15	1 year
4.	BiLog Antenna	VULB9163	9163 330	Schwarzbeck	2017.04.22	3 years
5.	LISN	ESH2-Z5	100196	R&S	2018.01.05	1 year
6.	Horn Antenna	3117	00066585	ETS-Lindgren	2019.03.05	3 years
7.	Universal Radio Communication Tester	E5515C	GB44051324	Agilent	2017.05.18	1 year
8.	PC	2OET-A00DC D	PF-OIYDAK	Lenovo	/	/
9.	Printer	P1008	VNF6C12491	HP	/	/
10.	Mouse	MO28UOL	44B39412	Lenovo	/	/
11.	Chamber	FACT5-2.0	4166	ETS-Lindgren	2018.05.13	3 years

Project	Name	Version
Radiated Emission	EMC32	Version 10.01.00
Conducted Emission	EMC32	Version 8.53.0



# **ANNEX A: MEASUREMENT RESULTS**

## A.1 Radiated Emission (§15.109(a))

Reference

FCC: CFR Part 15.109(a)

#### A.1.1 Method of measurement

The field strength of radiated emissions from the unintentional radiator (USB mode of MS and charging mode of MS) at a distance of 3 meters is tested. Tested in accordance with the procedures of ANSI C63.4 - 2014, section 8.3.

The EUT was placed on a non-conductive table. The measurement antenna was placed at a distance of 3 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT. This maximization process was repeated with the EUT positioned in each of its three orthogonal orientations.

#### A.1.2 EUT Operating Mode:

The MS is operating in the USB mode and charging mode. During the test MS is connected to a PC via a USB cable in the case of USB mode and is connected to a charger in the case of charging mode. The model of the PC is Lenovo 2OET-A00DCD, and the serial number of the PC is PF-OIYDAK. The software is used to let the PC keep on copying data to MS, reading and erasing the data after copy action was finished.

#### A.1.3 Measurement Limit

Limit from CFR Part 15.109(a)

Frequency range	Field strength limit (μV/m)		
(MHz)	Quasi-peak Average		Peak
30-88	100		
88-216	150		
216-960	200		
960-1000	500		
>1000		500	5000

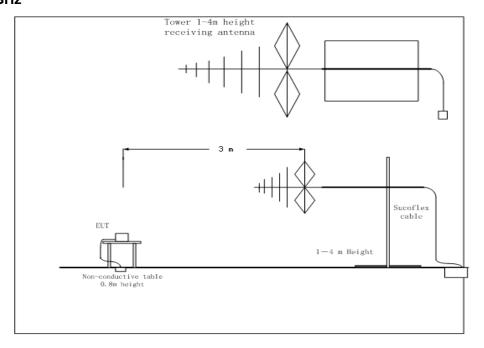
<sup>\*</sup>Note: The original limit is defined at 10m test distance. This limit is calculated according to CISPR requirements.

#### A.1.4 Test Condition

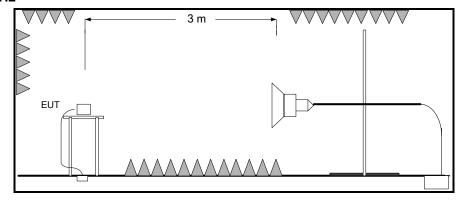
Frequency of emission (MHz)	RBW/VBW	Sweep Time(s)		
30-1000	120kHz (IF bandwidth)	5		
Above 1000	1MHz/3MHz	15		



# A.1.5 Test set-up: 30MHz-1GHz



## 1GHz-18GHz





#### A.1.6 Measurement Results

A "reference path loss" is established and the  $A_{Rpl}$  is the attenuation of "reference path loss". It includes the antenna factor of receive antenna and the path loss.

The measurement results are obtained as described below:

Result =  $P_{Mea} + A_{Rpl} = P_{Mea} + G_A + G_{PL}$ 

Where

GA: Antenna factor of receive antenna

G<sub>PL</sub>: Path Loss

 $P_{\text{Mea}}$ : Measurement result on receiver.

Note: the result contains vertical part and Horizontal part

RE Measurement uncertainty: 30M-1GHz: 5.12dB (k=2);

1GHz-18GHz: 4.48 dB (k=2)

#### Set.1 Charging mode / Peak detector

0 0						
Fraguero (MIII-)	Result(dBuV/m)	Limit	Margin(dB)	Polar	$A_Rpl$	P <sub>Mea</sub>
Frequency(MHz)	Result(dbdv/III)	(dBµV/m)	Margin(ub)	ity	(dB)	(dBµV)
14145.500000	55.69	74.00	18.31	<b>V</b>	11.2	44.49
15070.000000	55.58	74.00	18.42	V	12.1	43.48
15819.000000	57.43	74.00	16.57	V	12.8	44.63
16188.000000	57.40	74.00	16.60	V	13.1	44.3
16674.000000	58.57	74.00	15.43	V	13.8	44.77
17375.000000	58.73	74.00	15.27	V	14.0	44.73

## Set.1 Charging mode / Average detector

Fraguesov/MUz)	Popult(dPu\//m)	Limit	Margin(dP)	Polar	$A_{Rpl}$	P <sub>Mea</sub>
Frequency(MHz)	Result(dBuV/m)	(dBµV/m)	Margin(dB)	ity	(dB)	(dBµV)
14523.000000	43.64	54.00	10.36	V	11.8	31.84
15139.500000	44.39	54.00	9.61	V	12.1	32.29
15695.500000	45.67	54.00	8.33	V	12.7	32.97
16224.500000	45.97	54.00	8.03	V	13.1	32.87
16795.500000	46.63	54.00	7.37	V	13.9	32.73
17346.500000	45.94	54.00	8.06	V	14.0	31.94



## Set.2 USB mode / Peak detector

Fragues ov (MUz)	Result(dBuV/m)	Limit	Margin(dD)	Polar	$A_{Rpl}$	P <sub>Mea</sub>
Frequency(MHz)	Result(dbdv/III)	(dBµV/m)	Margin(dB)	ity	(dB)	(dBµV)
14093.000000	54.37	74.00	19.63	V	11.1	43.27
15095.000000	54.82	74.00	19.18	V	12.1	42.72
15697.000000	55.90	74.00	18.10	V	12.7	43.2
16420.500000	54.96	74.00	19.04	V	13.6	41.36
16772.000000	55.73	74.00	18.27	V	13.9	41.83
17334.000000	55.17	74.00	18.83	V	14.0	41.17

# Set.2 USB mode / Average detector

Fragues 20/(MHz)	Popult/dPu\//m\	Limit	Margin(dD)	Polar	$A_{Rpl}$	P <sub>Mea</sub>
Frequency(MHz)	Result(dBuV/m)	(dBµV/m)	Margin(dB)	ity	(dB)	(dBµV)
14529.000000	43.00	54.00	11.00	V	11.8	31.2
15075.500000	43.43	54.00	10.57	V	12.1	31.33
15774.500000	44.41	54.00	9.59	V	12.8	31.61
16232.000000	44.07	54.00	9.93	V	13.1	30.97
16844.000000	44.38	54.00	9.62	V	13.9	30.48
17351.500000	43.98	54.00	10.02	V	14.0	29.98



Charging mode: Set 1

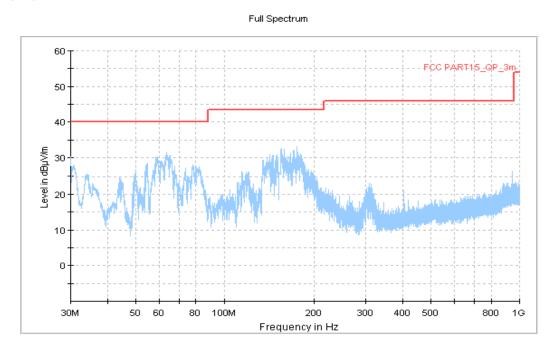


Figure A.1 Radiated Emission from 30MHz to 1GHz

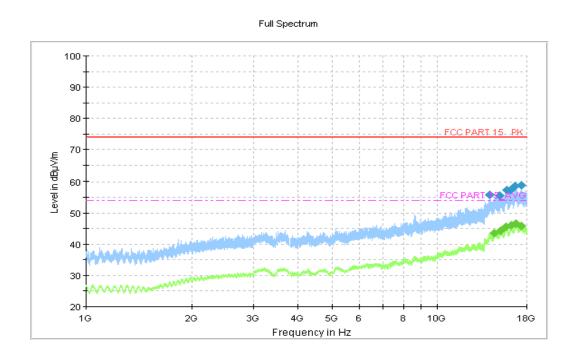


Figure A.2 Radiated Emission from 1GHz to 18GHz



**USB mode: Set 2** 

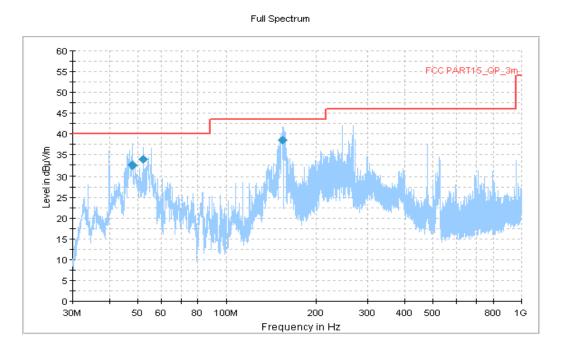


Figure A.3 Radiated Emission from 30MHz to 1GHz

## Final Result

Frequency	QuasiPeak	Limit	Margin Pol		Corr.
(MHz)	(dBµV/m)	(dBµV/m)	(dB)		(dB)
47.885000	32.64	40.00	7.36	V	-32.9
52.197000	33.98	40.00	6.02	V	-33.2
154.16600	38.56	43.52	4.96	Η	-37.5

Full Spectrum

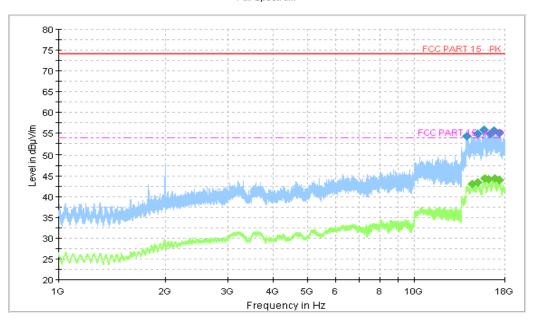


Figure A.4 Radiated Emission from 1GHz to 18GHz



## A.2 Conducted Emission (§15.107(a))

#### Reference

FCC: CFR Part 15.107(a)

#### A.2.1 Method of measurement

For equipment that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies within the band 150 kHz to 30 MHz shall not exceed the limits. Tested in accordance with the procedures of ANSI C63.4 - 2014, section 7.3.

### A.2.2 EUT Operating Mode:

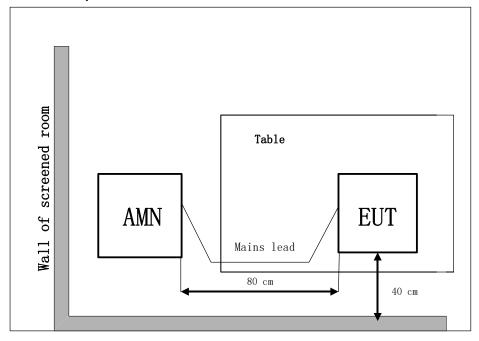
The MS is operating in the USB mode and charging mode. During the test MS is connected to a PC via a USB cable in the case of USB mode and is connected to a charger in the case of charging mode. The model of the PC is Lenovo 2OET-A00DCD, and the serial number of the PC is PF-OIYDAK. The software is used to let the PC keep on copying data to MS, reading and erasing the data after copy action was finished.

#### A.2.3 Measurement Limit

Frequency of emission (MHz)	Conducted limit (dBµV)					
	Quasi-peak	Average				
0.15-0.5	66 to 56*	56 to 46*				
0.5-5	56	46				
5-30 60 50						
*Decreases with the logarithm of the frequency						



## A.2.4 Test set-up:



# A.2.5 Test Condition in charging mode

Voltage (V)	Frequency (Hz)		
120	60		
240	60		

RBW	Sweep Time(s)
9kHz	1

CE Measurement uncertainty: 3.06 dB (k=2)



# A.2.6 Measurement Results Charging mode:Set.1 Voltage:120V

#### ESH2-Z5 Scan-FCC

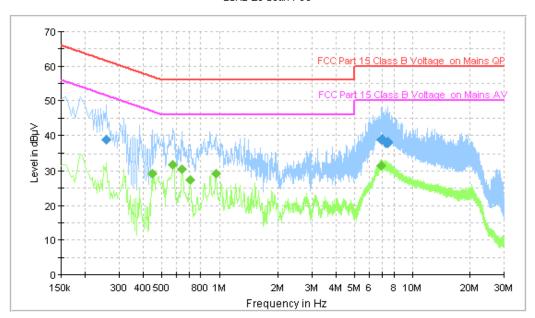


Figure A.5 Conducted Emission

#### **Final Measurement Detector 1**

Frequency	QuasiPeak	DE	т :	Corr.	Margin	Limit
(MHz)	(dBµV)	PE	Line	(dB)	(dB)	$(dB\mu V)$
0.258000	38.8	GND	N	9.6	22.7	61.5
6.922000	38.8	GND	N	9.7	21.2	60.0
6.946000	39.0	GND	N	9.7	21.0	60.0
7.250000	38.1	GND	N	9.8	21.9	60.0
7.406000	38.2	GND	N	9.8	21.8	60.0
7.438000	38.1	GND	N	9.8	21.9	60.0

Frequency (MHz)	Average (dBµV)	PE	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.450000	29.2	GND	N	9.7	17.7	46.9
0.430000	29.2	GND	IN	9.7	17.7	40.9
0.574000	31.9	GND	N	9.7	14.1	46.0
0.642000	30.5	GND	N	9.6	15.5	46.0
0.702000	27.4	GND	N	9.5	18.6	46.0
0.958000	29.1	GND	N	9.6	16.9	46.0
6.878000	31.6	GND	N	9.7	18.4	50.0



USB mode:Set.2 Voltage:120V

#### ESH2-Z5 Scan-FCC

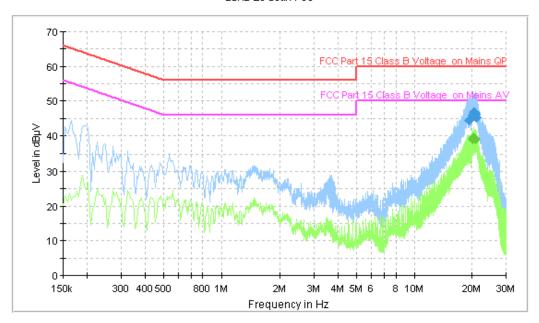


Figure A.6 Conducted Emission

## **Final Measurement Detector 1**

Frequency	QuasiPeak	PE	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	PE	Line	(dB)	(dB)	(dBµV)
19.182000	44.5	GND	N	10.0	15.5	60.0
20.086000	45.9	GND	N	10.0	14.1	60.0
20.394000	46.8	GND	N	10.0	13.2	60.0
20.570000	46.7	GND	N	10.0	13.3	60.0
20.734000	46.3	GND	N	10.0	13.7	60.0
21.034000	45.3	GND	N	10.0	14.7	60.0

Frequency	Average	PE	Line	Corr.	Margin	Limit
(MHz)	(dBµV)	1 L	Line	(dB)	(dB)	(dBµV)
20.170000	39.0	GND	N	10.0	11.0	50.0
20.278000	39.2	GND	N	10.0	10.9	50.0
20.446000	39.4	GND	N	10.0	10.6	50.0
20.462000	39.4	GND	N	10.0	10.6	50.0
20.470000	39.4	GND	N	10.0	10.6	50.0
20.750000	39.0	GND	N	10.0	11.0	50.0



# Charging mode:Set.1 Voltage:240V

#### ESH2-Z5 Scan-FCC

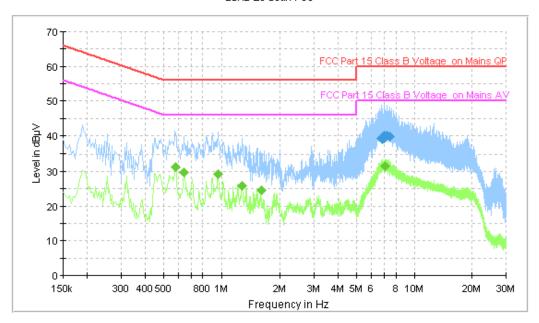


Figure A.7 Conducted Emission

## **Final Measurement Detector 1**

Frequency	QuasiPeak	PE	Line	Corr.	Margin	Limit
(MHz)	(dBµV)			(dB)	(dB)	(dBµV)
6.754000	39.3	GND	N	9.7	20.7	60.0
6.846000	38.9	GND	N	9.7	21.1	60.0
6.986000	39.2	GND	N	9.7	20.8	60.0
6.998000	40.0	GND	N	9.7	20.0	60.0
7.170000	40.0	GND	N	9.7	20.0	60.0
7.438000	39.8	GND	N	9.8	20.2	60.0

Frequency (MHz)	Average (dBµV)	PE	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.578000	31.2	GND	N	9.6	14.8	46.0
0.642000	29.8	GND	N	9.6	16.2	46.0
0.962000	29.3	GND	N	9.6	16.7	46.0
1.282000	25.9	GND	N	9.6	20.1	46.0
1.602000	24.4	GND	N	9.6	21.6	46.0
7.066000	31.5	GND	N	9.7	18.5	50.0



USB mode:Set.2 Voltage:240V

ESH2-Z5 Scan-FCC

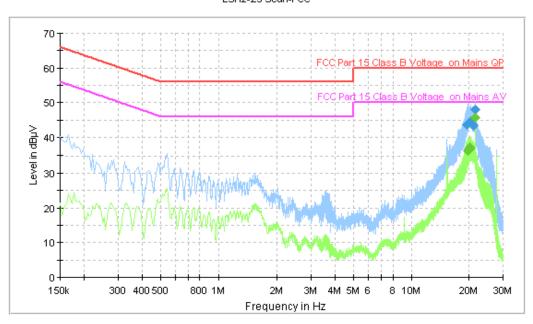


Figure A.8 Conducted Emission

## **Final Measurement Detector 1**

Frequency	QuasiPeak	PE	т :	Corr.	Margin	Limit
(MHz)	(dBµV)	PE	Line	(dB)	(dB)	(dBµV)
19.570000	43.6	GND	N	10.0	16.4	60.0
19.766000	43.9	GND	N	10.0	16.1	60.0
20.282000	44.8	GND	N	10.0	15.2	60.0
20.746000	43.8	GND	N	10.0	16.2	60.0
21.038000	43.3	GND	N	10.0	16.7	60.0
21.506000	48.0	GND	N	10.0	12.0	60.0

Frequency (MHz)	Average (dBµV)	PE	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
, ,				` ′	` ′	
19.782000	36.4	GND	N	10.0	13.6	50.0
19.974000	36.8	GND	N	10.0	13.2	50.0
20.050000	37.0	GND	N	10.0	13.0	50.0
20.142000	37.0	GND	N	10.0	13.0	50.0
20.182000	37.2	GND	N	10.0	12.8	50.0
21.506000	45.7	GND	N	10.0	4.3	50.0